## FDS6672A 30V N-Channel PowerTrench<sup>®</sup> MOSFET

## Sov N-Chaimer Tower Trench

## **General Description**

-AIRCHILD

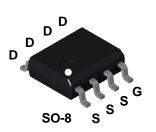
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{DS(ON)}$  and fast switching speed.

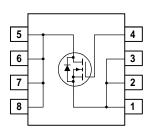
## Applications

• DC/DC converter

## Features

- 12.5 A, 30 V.  $R_{DS(ON)} = 8 \ m\Omega @ V_{GS} = 10 \ V$  $R_{DS(ON)} = 9.5 \ m\Omega @ V_{GS} = 4.5 \ V$
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- Low gate charge (33 nC typical)
- High power and current handling capability





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage		30	V	
V <sub>GSS</sub>	Gate-Source Voltage		±12	V	
I <sub>D</sub>	Drain Current – Continuous	(Note 1a)	12.5	A	
	- Pulsed		50		
PD	Power Dissipation for Single Operation	(Note 1a)	2.5	W	
		(Note 1b)	1.2		
		(Note 1c)	1.0		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C	
Therma	I Characteristics	·		·	
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W	

## R<sub>0JA</sub> Thermal Resistance, Junction-to-Ambient (Note 1a) 50 °C/W R<sub>0JC</sub> Thermal Resistance, Junction-to-Case (Note 1) 25 °C/W

## Package Marking and Ordering Information

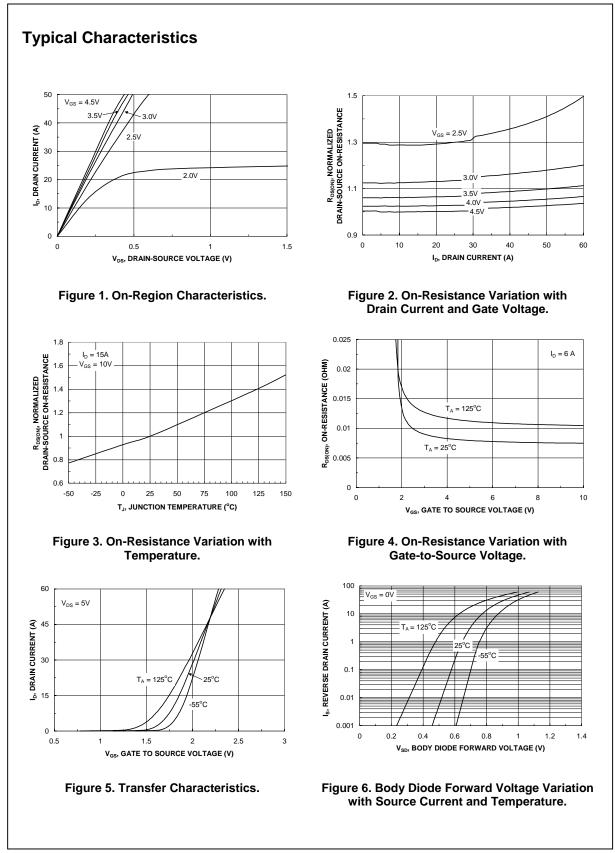
Device Marking	Device	Reel Size	Tape width	Quantity
FDS6672A	FDS6672A	13"	12mm	2500 units

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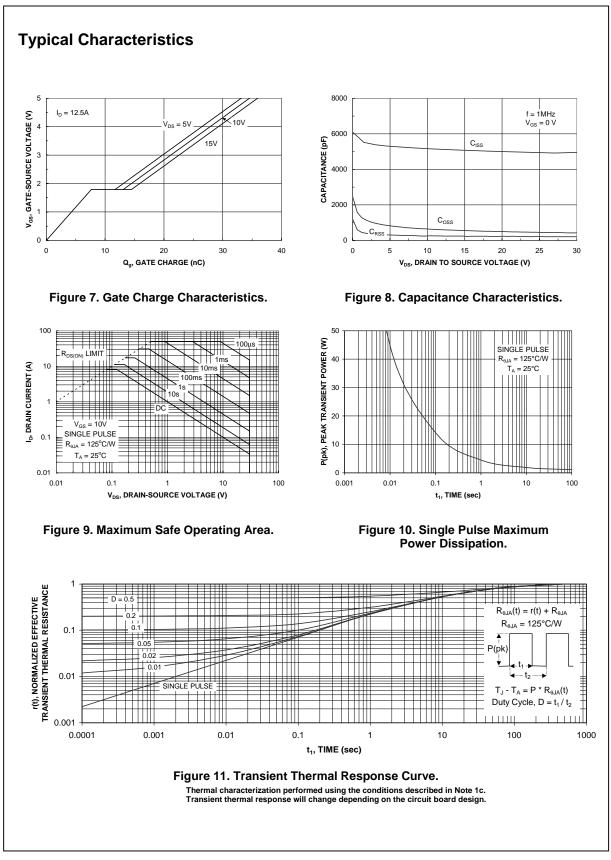
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	racteristics				1	1
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V
$\Delta BV_{DSS} \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -12 V V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)			L	L	<b></b>
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.8	1.2	2.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to 25°C		-4		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance			6.8 8.2 11.5	8 9.5 16	mΩ
I <sub>D(on)</sub>	On–State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	50			A
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10 V$ , $I_{D} = 15 A$		75		S
Dvnami	c Characteristics					
Ciss	Input Capacitance	$V_{DS} = 15 V$ , $V_{GS} = 0 V$ ,		5070		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		550		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			230		pF
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn–On Delay Time	$V_{\text{DD}} = 10 \text{ V},  I_{\text{D}} = 1 \text{ A},$	1	17	25	ns
tr	Turn–On Rise Time	$V_{GS} = 4.5 V, R_{GEN} = 6 \Omega$		18	25	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			69	100	ns
t <sub>f</sub>	Turn–Off Fall Time			29	42	ns
Qg	Total Gate Charge	$V_{DS} = 15 \text{ V}, \ I_{D} = 15 \text{ A},$		33	46	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 4.5 V$		7.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			6.8		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				2.1	Α
$V_{\text{SD}}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 2.1 A$ (Note 2)		0.7	1.2	V
	n of the junction-to-case and case-to-ambient then $R_{eJC}$ is guaranteed by design while $R_{eCA}$ is detern a) 50°/W when		ט ע	as the solde		

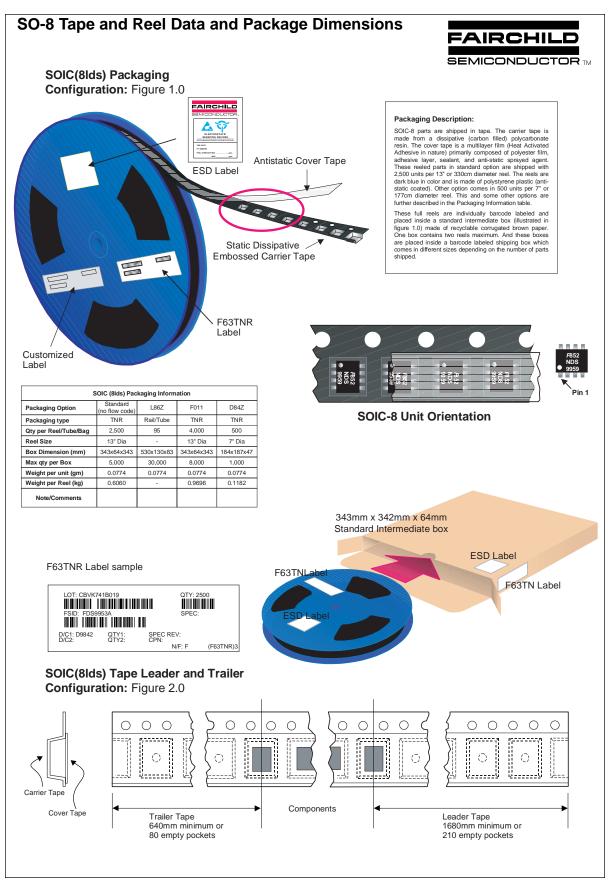
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

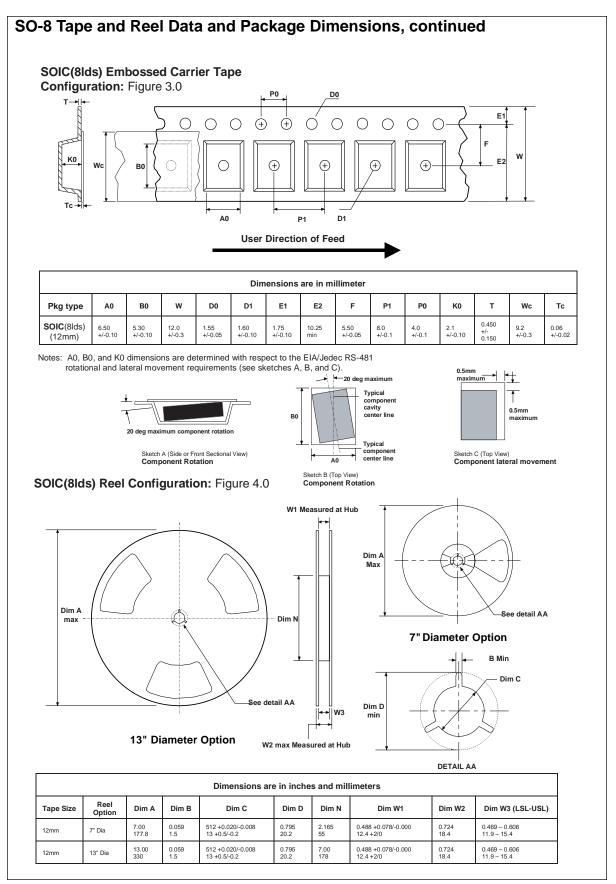


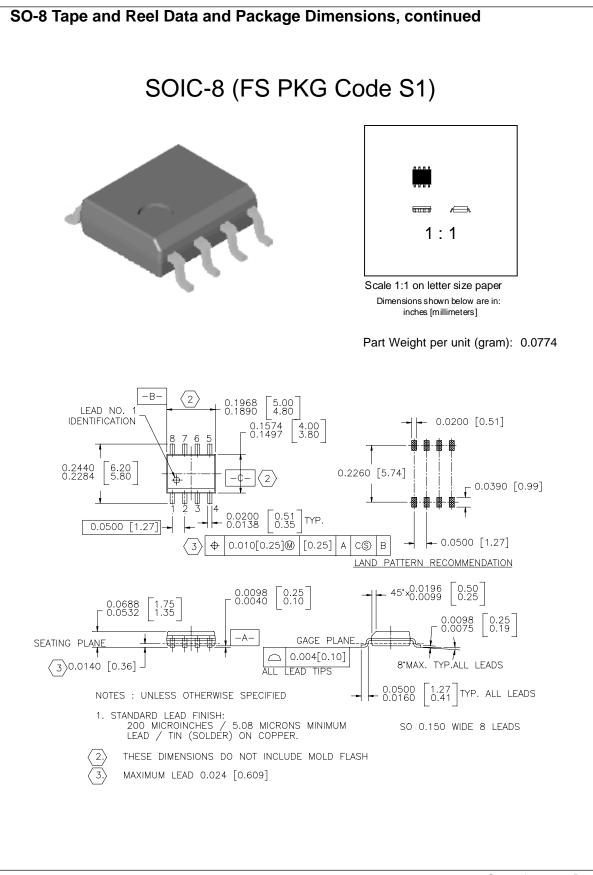
FDS6672A Rev B(W)





July 1999, Rev. B





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